

Low Light Level CCD Performance and Issues

**Nagaraja Bezawada
UK Astronomy Technology Centre**

04 July 2007

Overview of the Talk

Introduction to L3CCD (EM CCD)

ULTRASPEC

Performance and Issues

New L3 CCD Proposal



Introduction to L3CCD

Conventional CCD

Close to ideal performance

Read noise $\sim 3e^-$ (low readout rates)

Long time to readout

Noise increases with pixel rate

Readout noise dominates in low light level applications

Increase S/N

Reduce read noise

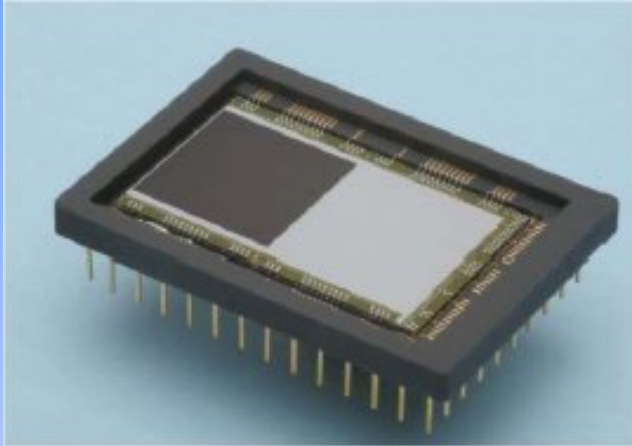
Boost the input signal

Integrate longer

Photo-multiply before readout

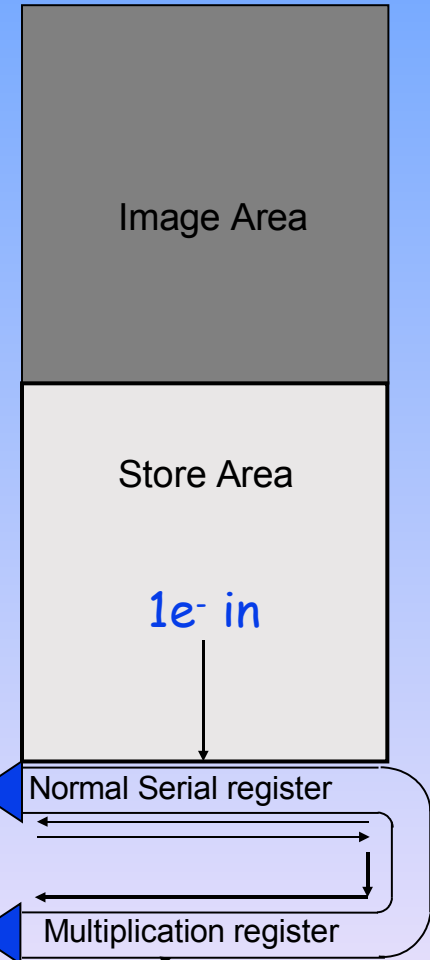


Low Light Level CCD



CCD201 1024x1024

Electron multiplication takes place in avalanche gain Register using an HV clock (38-43Volts).



$$\frac{S}{N} = \frac{S}{\sqrt{S+R^2}}$$

Standard output

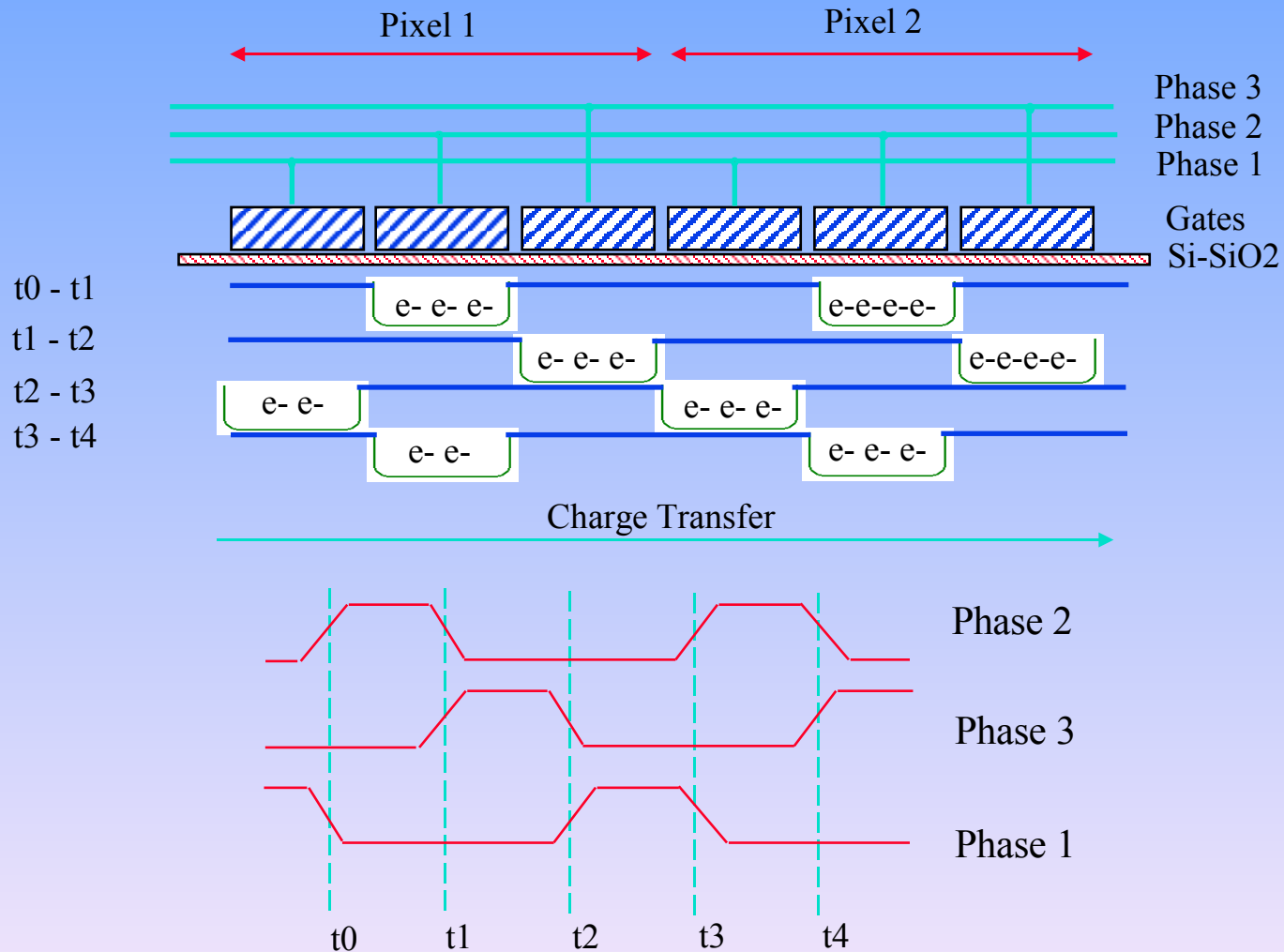
$$\frac{S}{N} = \frac{S}{\sqrt{S + \left(\frac{R}{g}\right)^2}}$$

Gain term

1000e⁻ signal out

High voltage clock

Charge Coupling Mechanism



Avalanche Gain Mechanism

Impact Ionisation

High electric field set by HV clock $\sim 100\text{kV/cm}$

Two electrodes – one at fixed DC, other clocked HV

Transferring electrons collide with crystal lattice and liberate new electrons

These liberate further new electrons

Probability is 1 - 2% per stage

$$\text{Gain} = (1+P)^N$$

Depends on number of gain stages

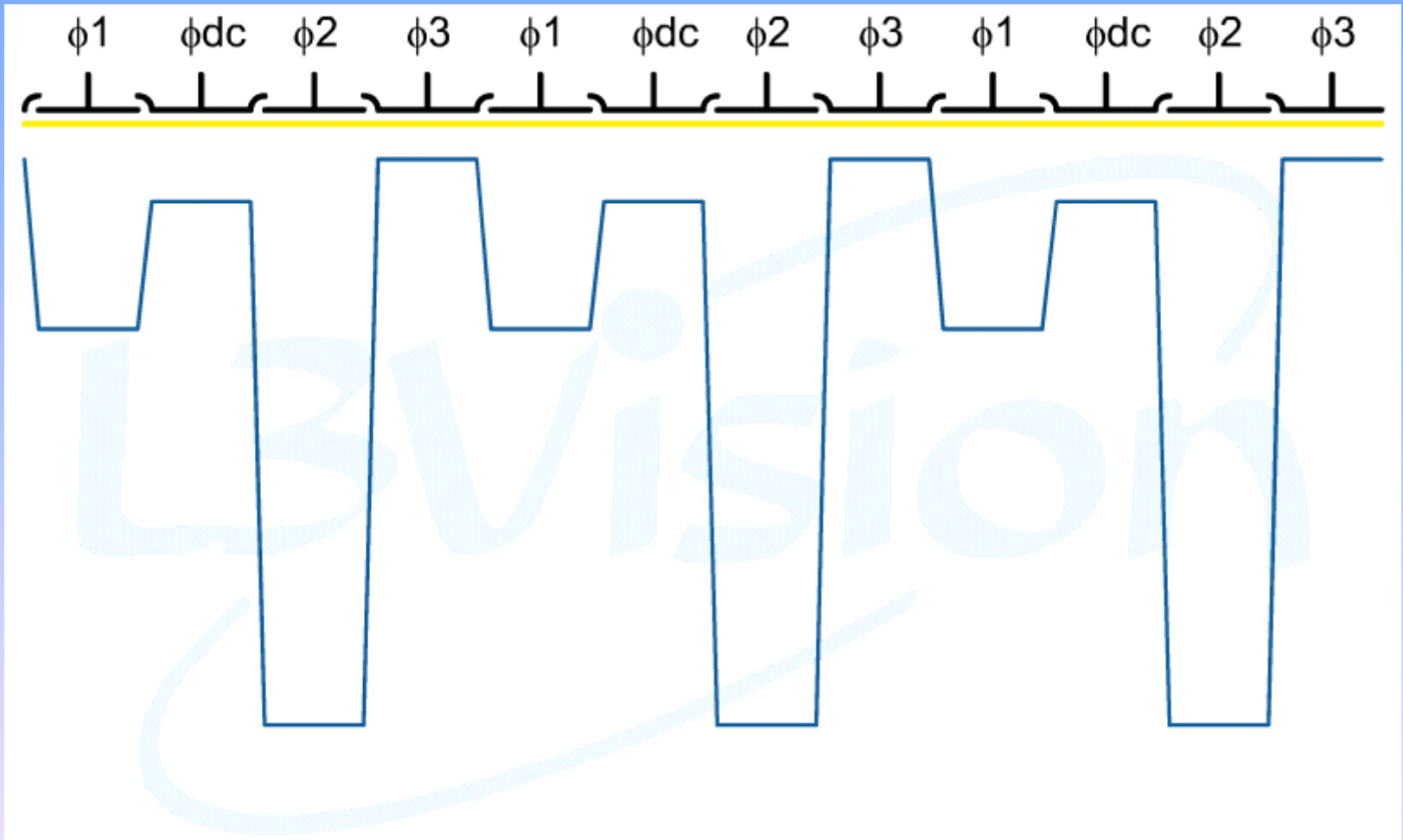
Applied electric field

Operating temperature

A 600 stage gain register with 0.015 probability can give ~ 7500 signal gain



Electron Multiplication



Avalanche Gain Process

Statistical Process

Mean gain

Variance in the gain

Increases the variance in the output signal by 2

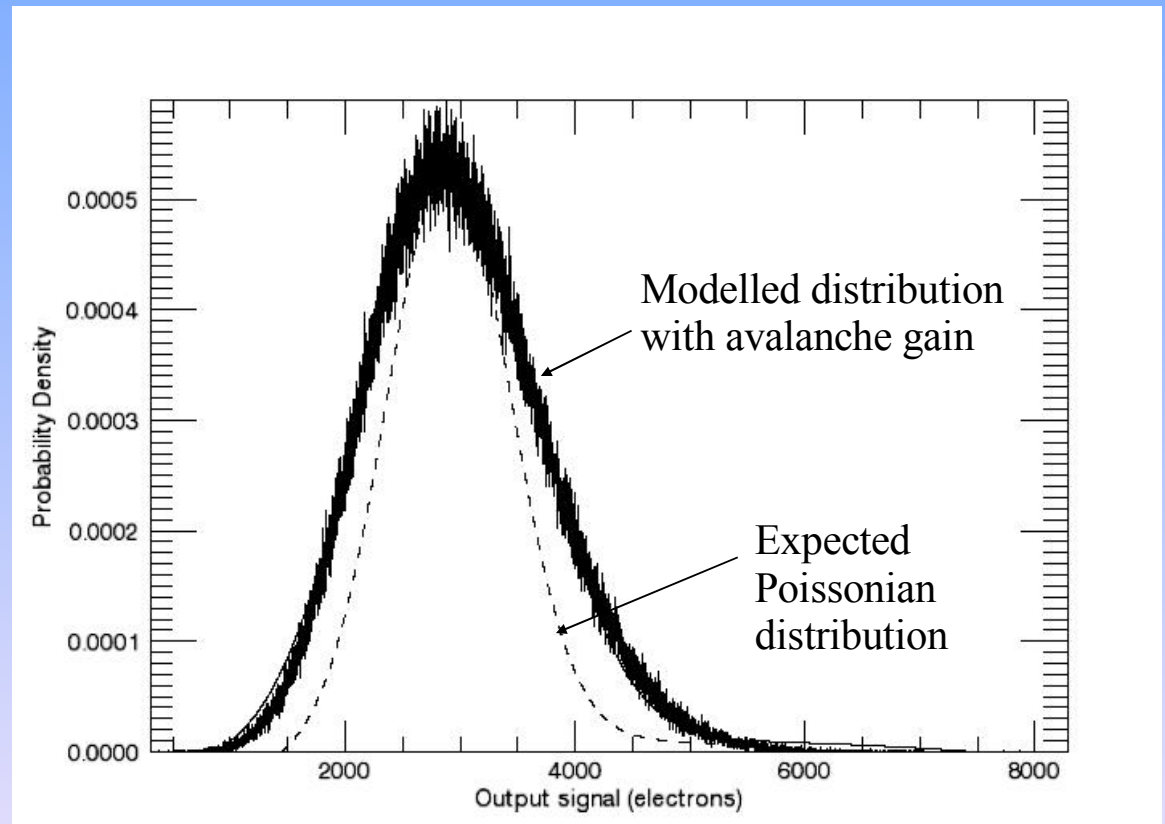
Effective QE reduces by factor of 2



Monte-Carlo Analysis of the Gain process

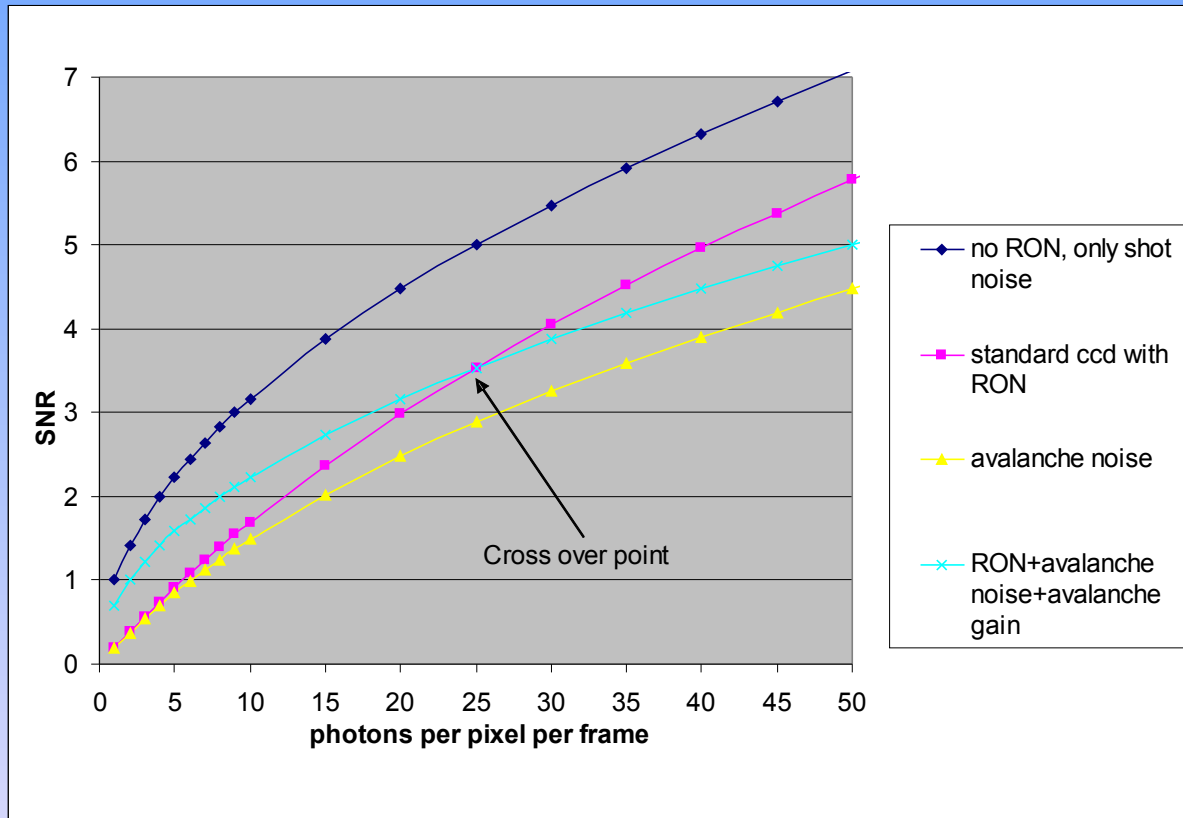
The sigma of the distribution is $\sqrt{2}$ times higher than the Poissonian distribution

$$\frac{S}{N} = \frac{S}{\sqrt{2S + \left(\frac{R}{g}\right)^2}}$$



Input = $30e^-$, Avalanche gain = 100

L3 CCD Wins in Low Light Regime



High time resolution imaging, spectroscopy

Adaptive optics

Photon counting

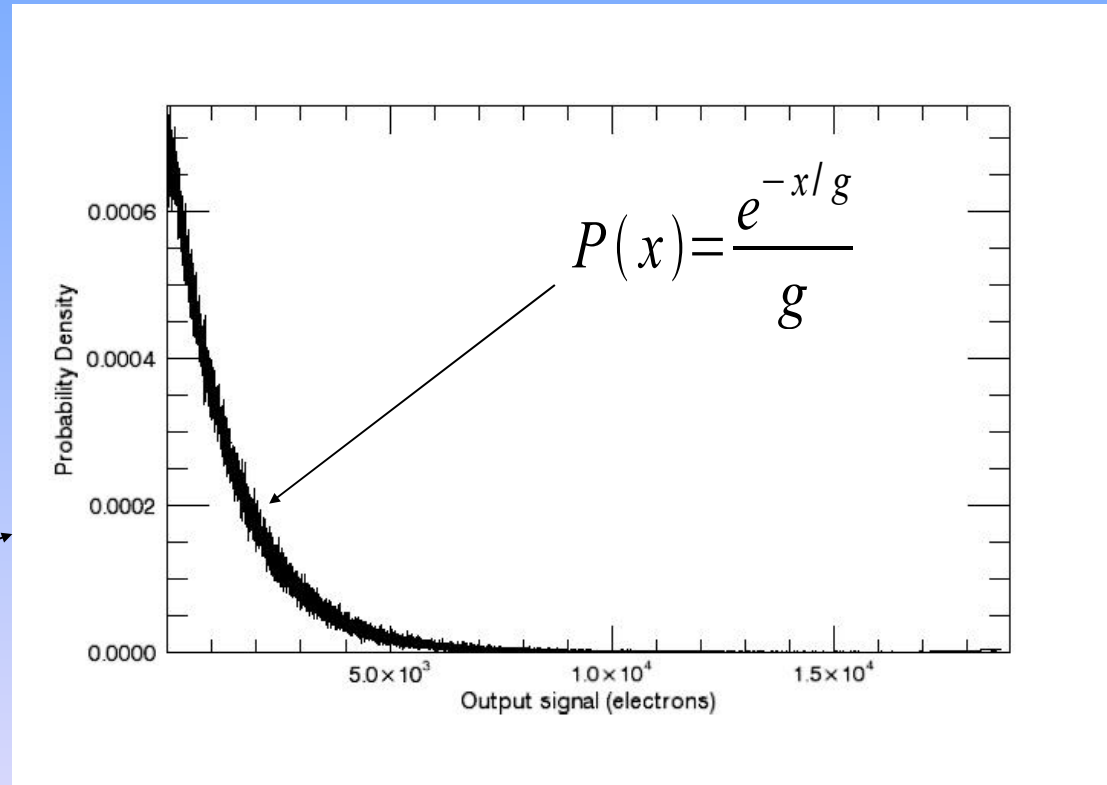
Lucky Astronomy

Even with the gain variance, the L3CCD wins over the standard CCD for low light level applications

Gain of the Multiplication Register

Statistics of the multiplication process give range of output values for 1e input events

Monte-Carlo simulation using IDL for 1e input events



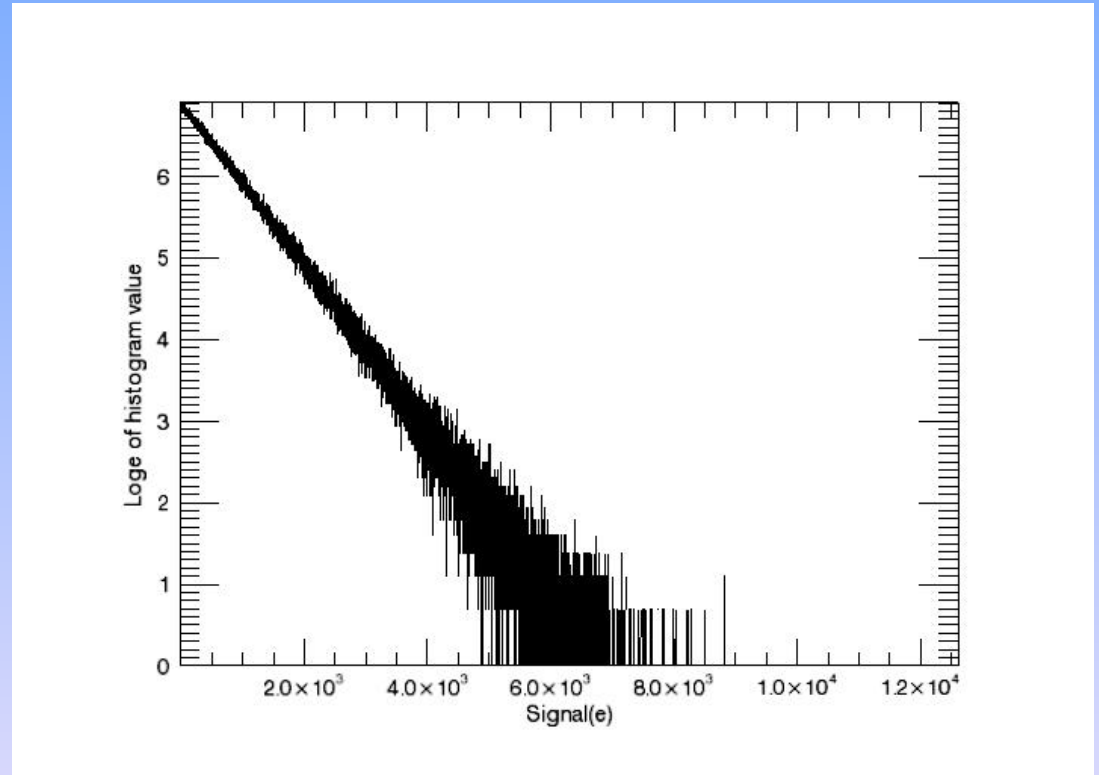
Input = $1e^-$, Avalanche gain = 1000

Gain of the Multiplication Register

Plot Log e of the histogram

The inverse slope gives the gain of the avalanche register

Gain calculated this way agrees very well when compared with standard output



Talk Overview

Introduction to L3CCD (EM CCD)

ULTRASPEC

Performance and Issues

New L3 CCD Proposal



ULTRASPEC

ULTRASPEC – high speed spectro-photometer camera commissioned on ESO La Silla 3.6 m telescope on EFOSC instrument

Based on new Electron Multiplication CCD technology – OPTICON funded project to show benefits of this technology

Frame transfer architecture also given read out efficiency improvements

New high voltage clock board developed for SDSU-III controller



E2V CCD201

1K Frame Transfer
CCD

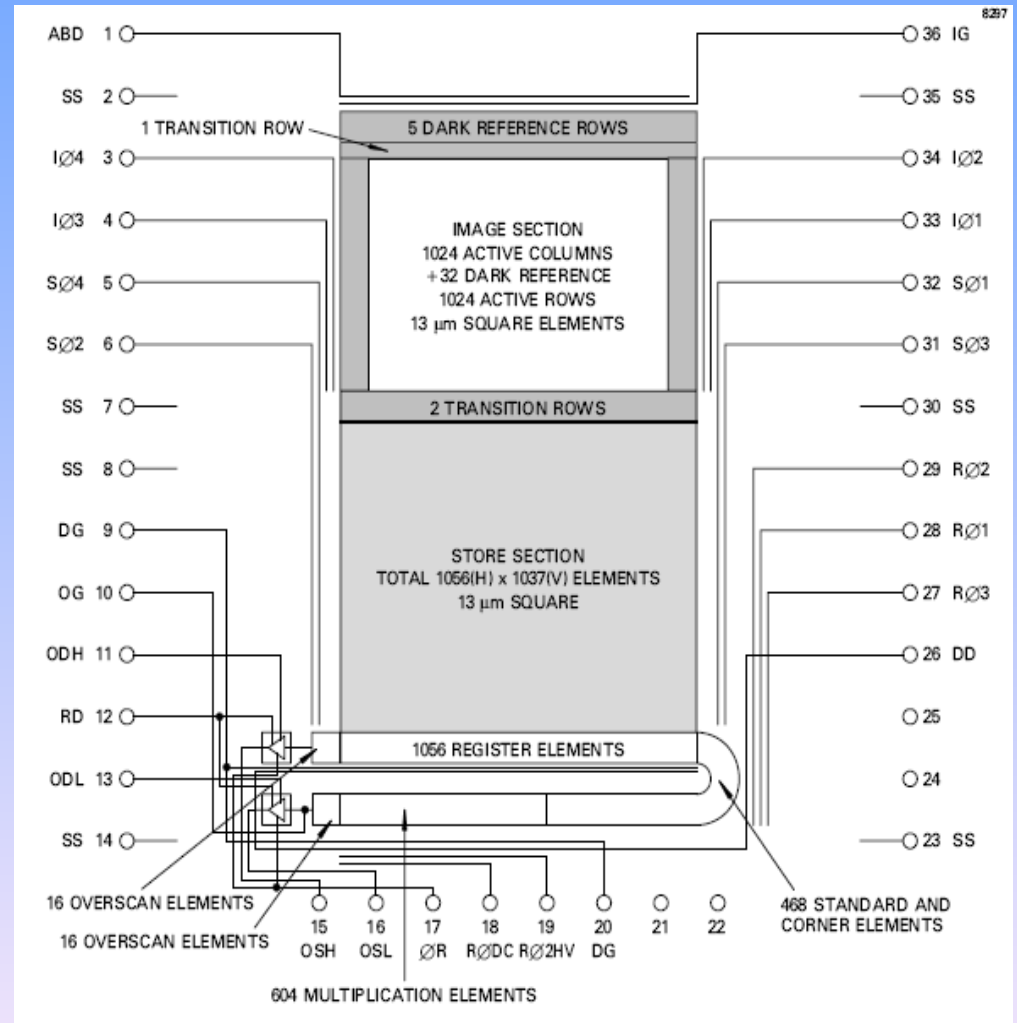
2-Phase Image /
storage registers

Two Outputs

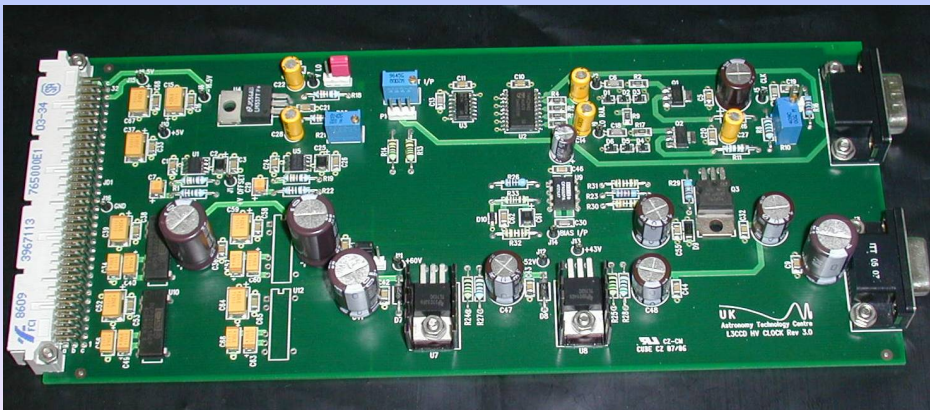
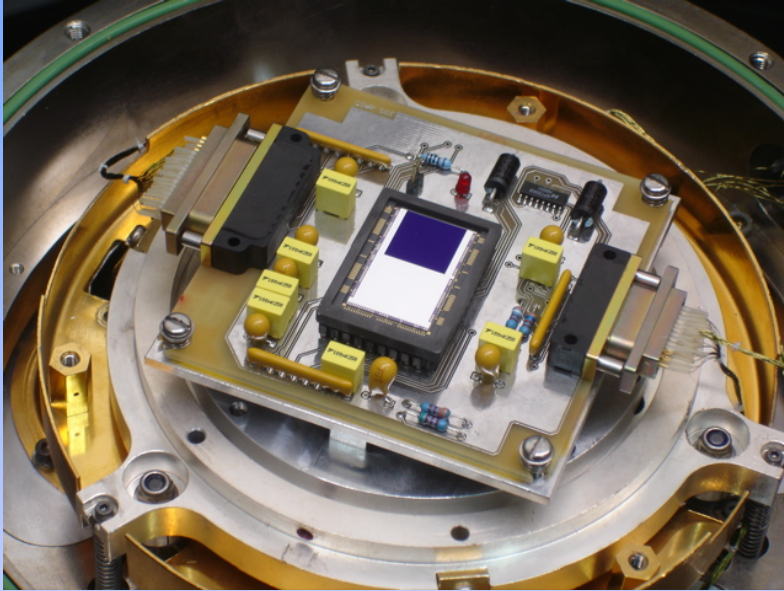
Conventional
output

Avalanche output

604 Multiplication
elements



ULTRASPEC – High-speed Spectroscopy with zero read noise



Talk Overview

Introduction to L3CCD (EM CCD)

ULTRASPEC

Performance and Issues

New L3 CCD Proposal

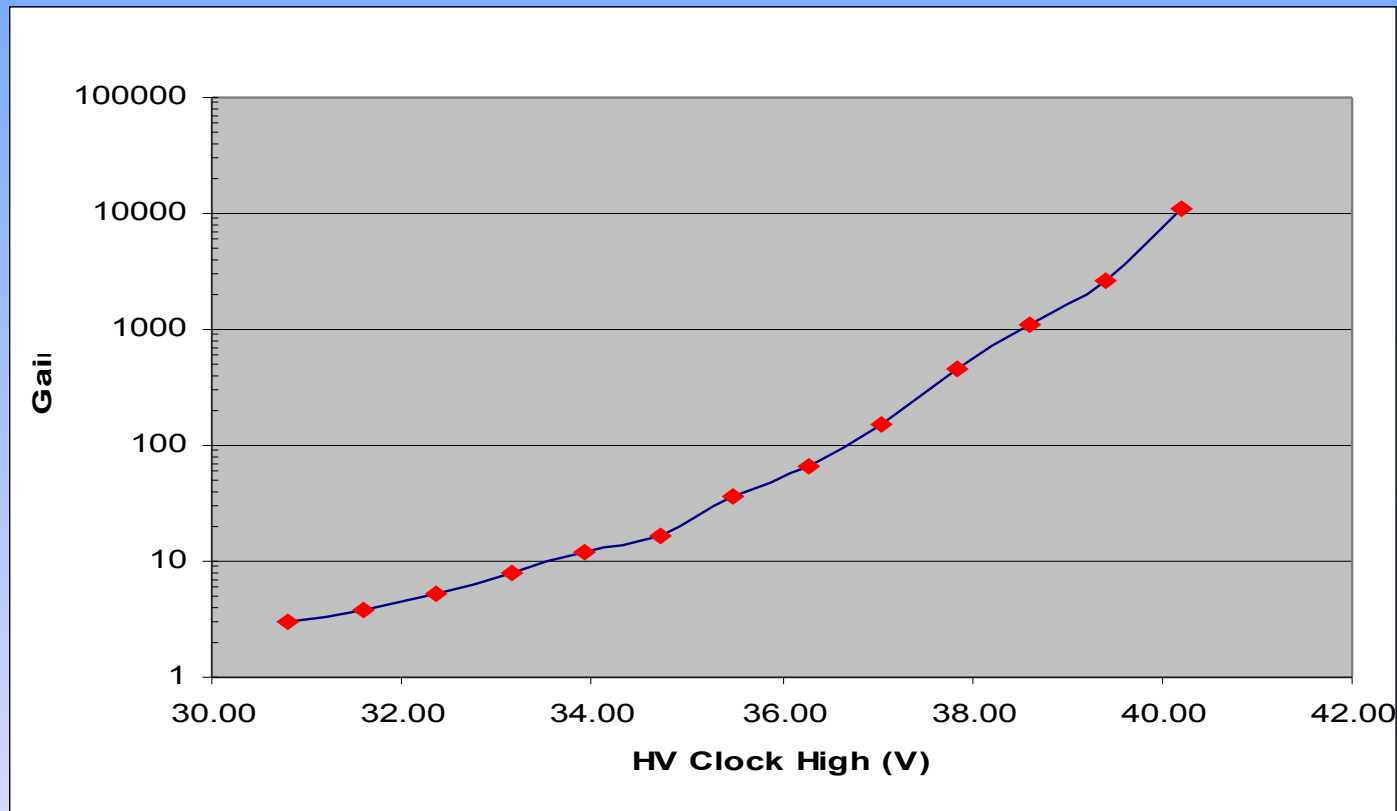


Performance – Read Noise

Parameter	Normal Output		Avalanche Output (Avalanche Gain = 1)	
	Slow Speed	Fast Speed	Slow Speed	Fast Speed
Gain (e/DN)	0.8	3.1	4.1	15.5
Read Noise	4.0e	10.2e	10.6e	24.7e
Frame time	4.8s	1.7s	9.7s	3.4s
Window (Y=100)	0.24s	0.09s	0.46s	0.17s



Gain Controlled by HV Clock

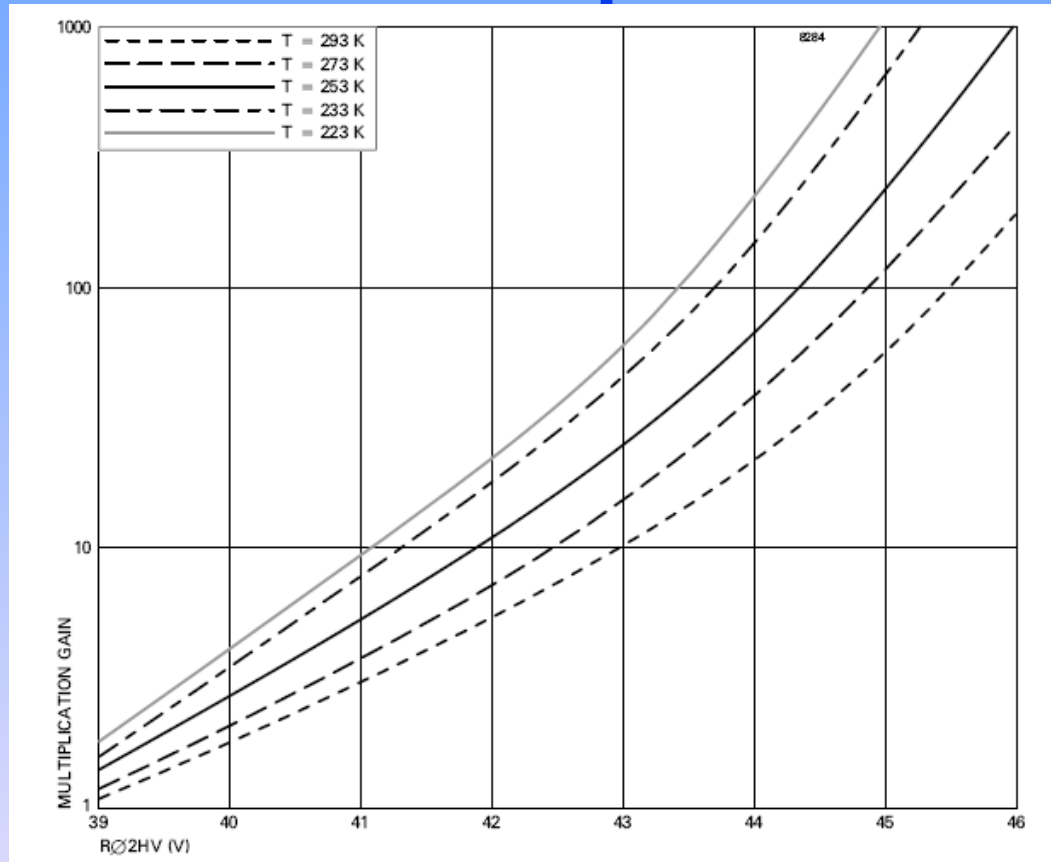


Under software control

Possible to have different gain for different parts of the CCD

Gain can also be switched off – no gain noise

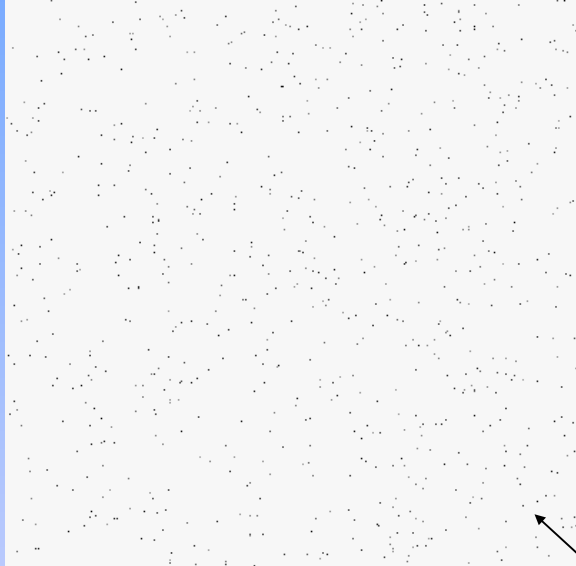
Gain Varies with Temperature



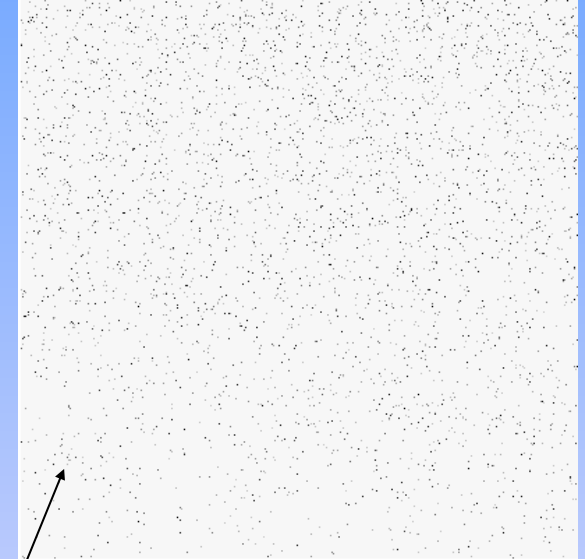
Gain increases at lower temperature due to increased probability of the impact ionisation

Lattice vibrations are less at lower temperatures

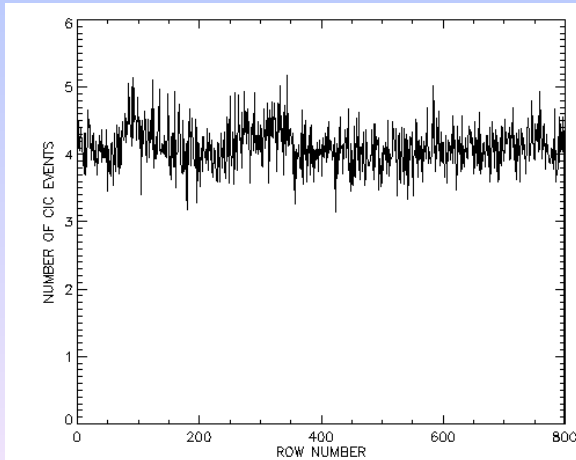
Clock Induced Charge



Clock induced charge occurs in every CCD
Dominated by readout noise in standard CCD

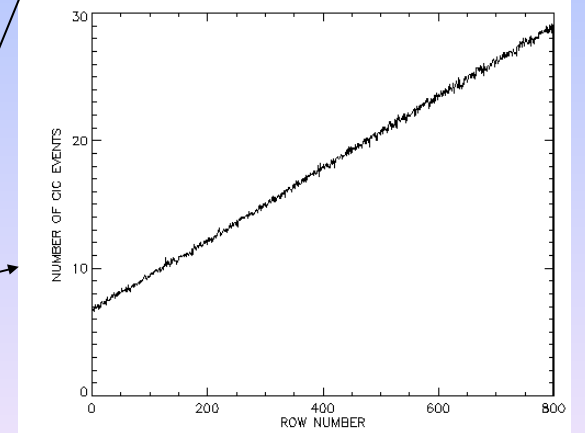


$$\frac{S}{N} = \frac{S}{\sqrt{2S + \left(\frac{R}{g}\right)^2 + C}}$$



Serial register only

Serial and prallel

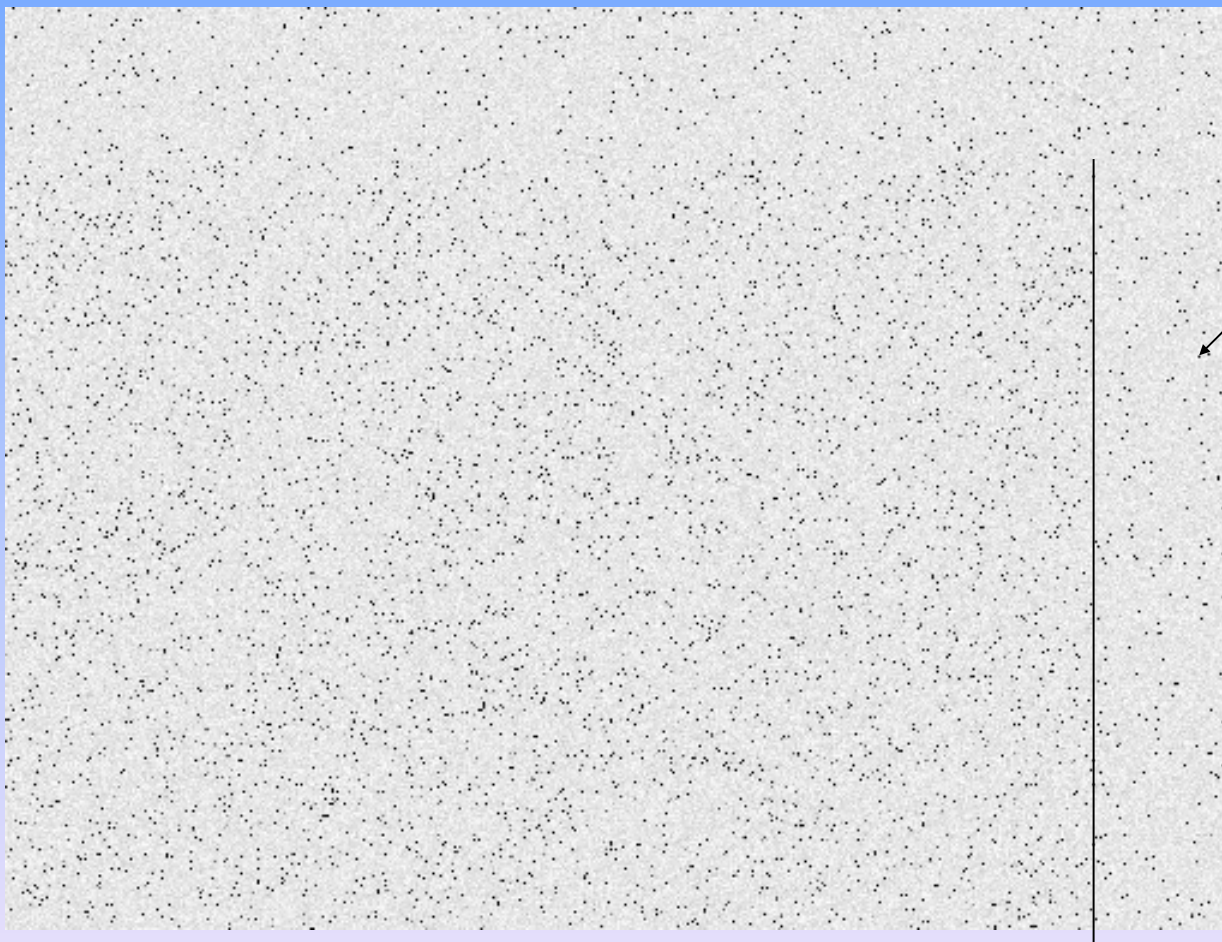


Performance - CIC

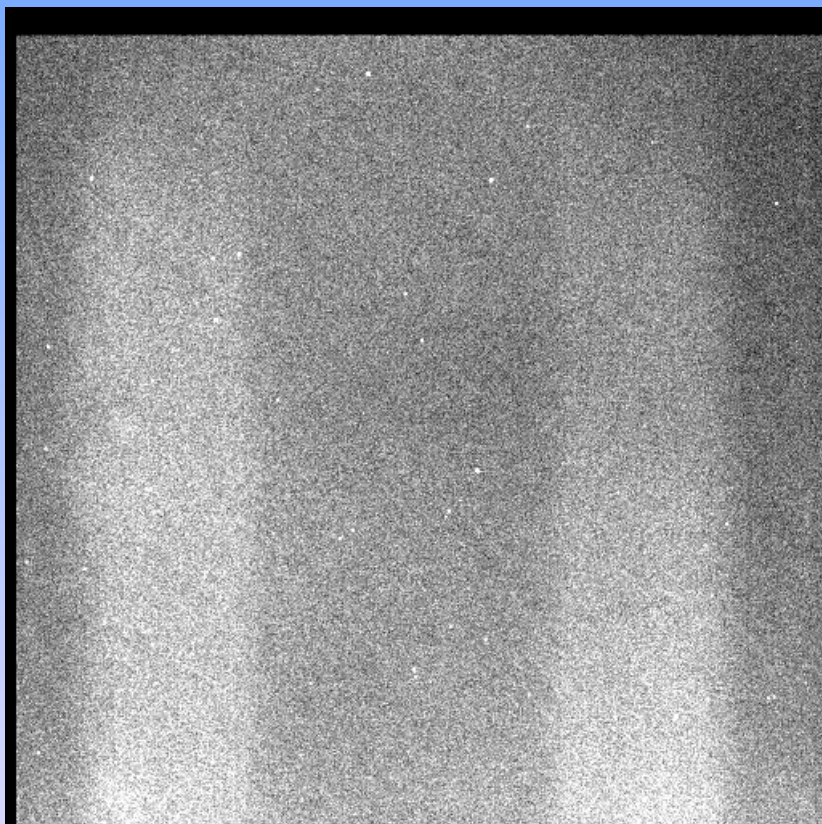
Average CIC in a frame	=	10.23 ADU
System Sensitivity	=	221.29 ADU/e
Avalanche Gain	=	1055.29
Transimpedance	=	0.0045 e/ADU
Read Noise	=	0.013 e = 2.94 ADU
Average CIC in a frame	=	0.046 e/pixel/frame



CIC Simulated



L3 Performance – Dark



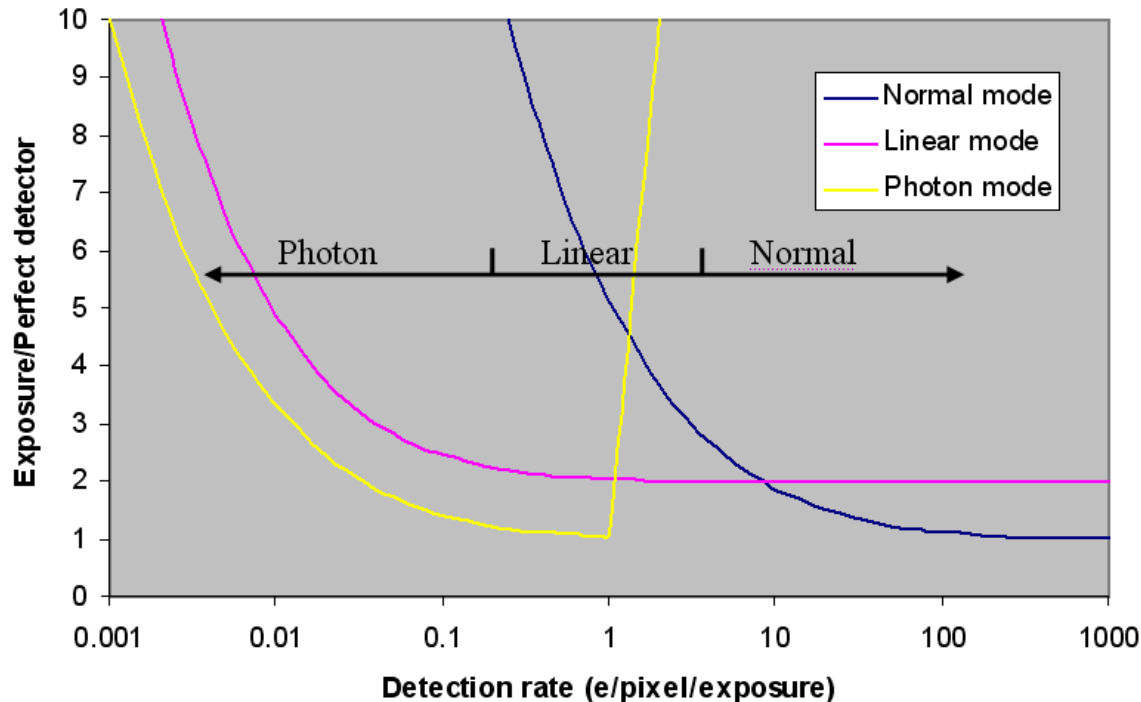
Non-inverted operation



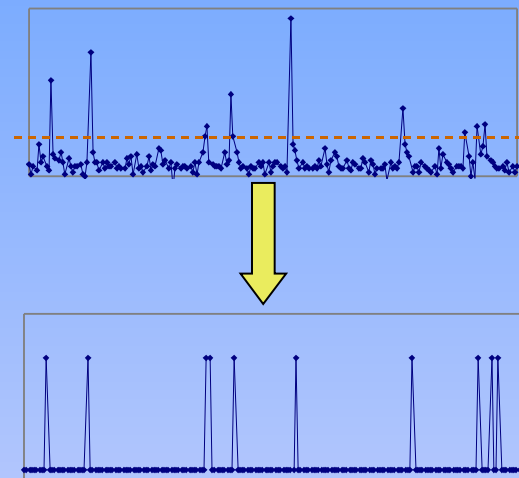
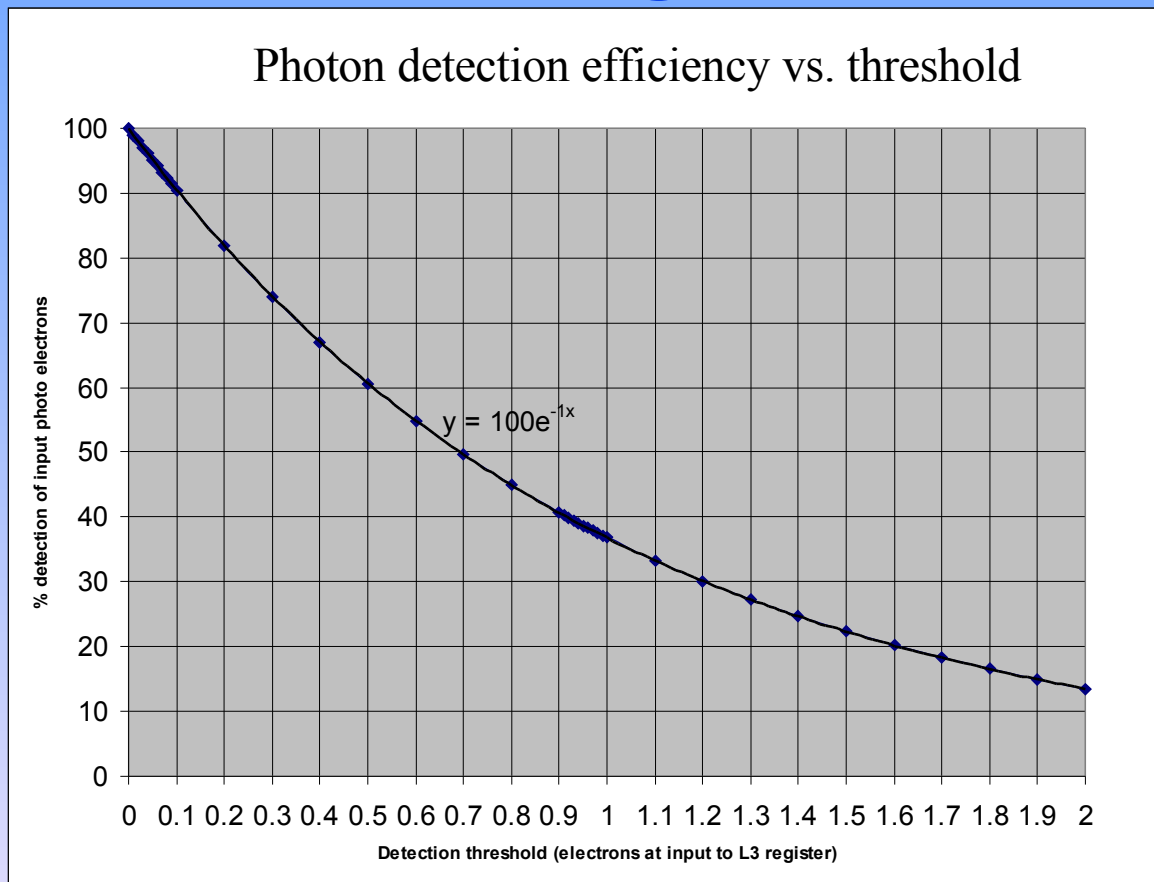
Inverted operation

Operating Regimes

The three operating modes of an EMCCD, shown in terms of the exposure time required to reach a given signal to noise ratio compared to a perfect shot noise limited detector, all else being equal.



Photon Counting



- No loss in S/N
- Ideal performance
- Low CIC
- Critical threshold

Threshold is normally set at 5σ

Avalanche gain is set at 10 times of the threshold

Normal vs. Avalanche Outputs

L3 Camera commissioned with EFOSC2 at ESO's 3.6m Telescope in La Silla (Dec. 06)

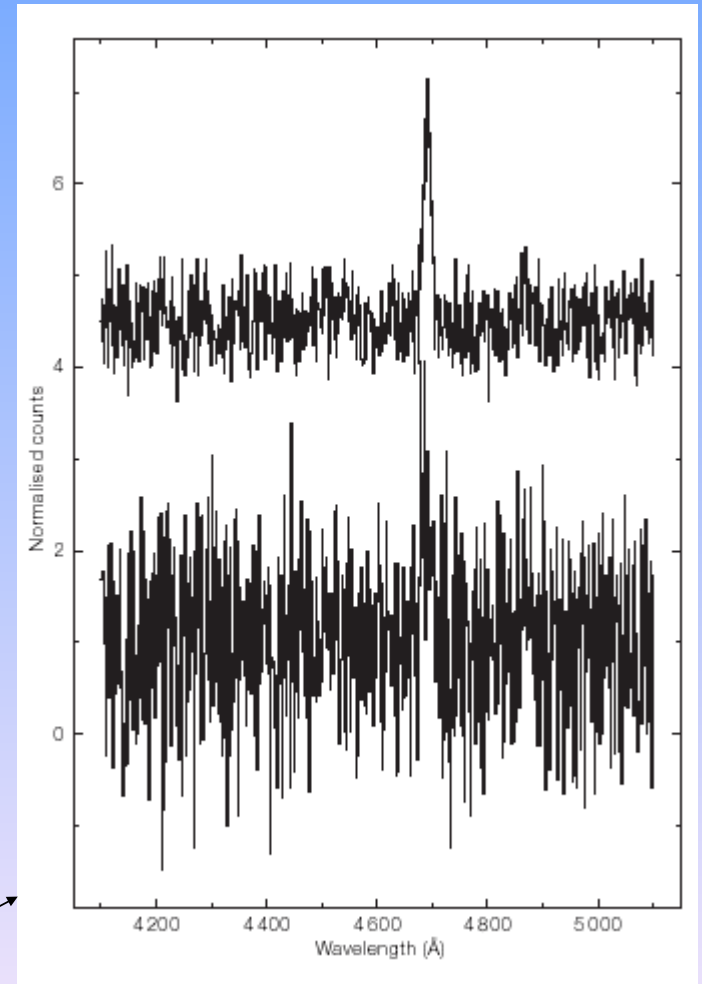
Top: 10s Spectrum using avalanche output of the UltraSpec

Bottom: 10s of Spectrum using normal output (conventional CCDs)

S/N Gain: Factor of three

3.6m Telescope with L3 CCD is equivalent to 6.4m telescope with conventional CCD

Dead time negligible with EM CCDs compared to the conventional CCDs



ESO Messenger, March 07

Ageing Effect

Drop in multiplication gain over time

Shift in the high voltage clock amplitude

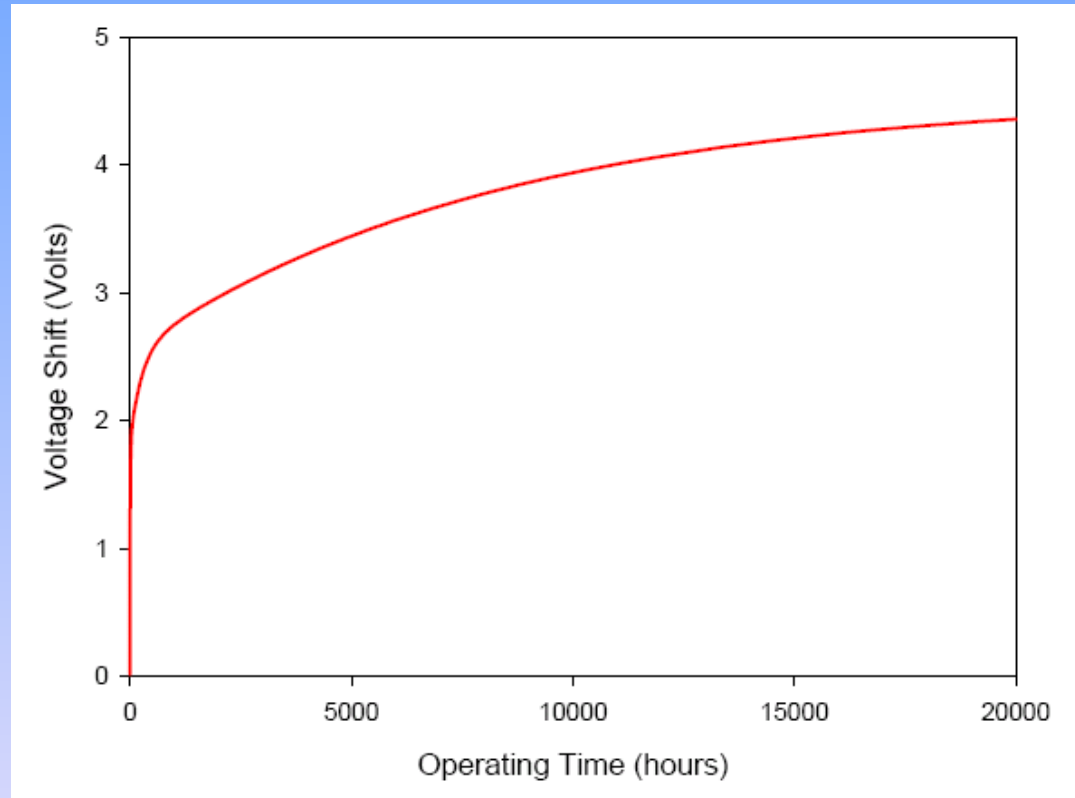
Ageing time constants

Short term

Long term

Depends on signal size

Function of gain



Talk Overview

Introduction to L3CCD (EM CCD)

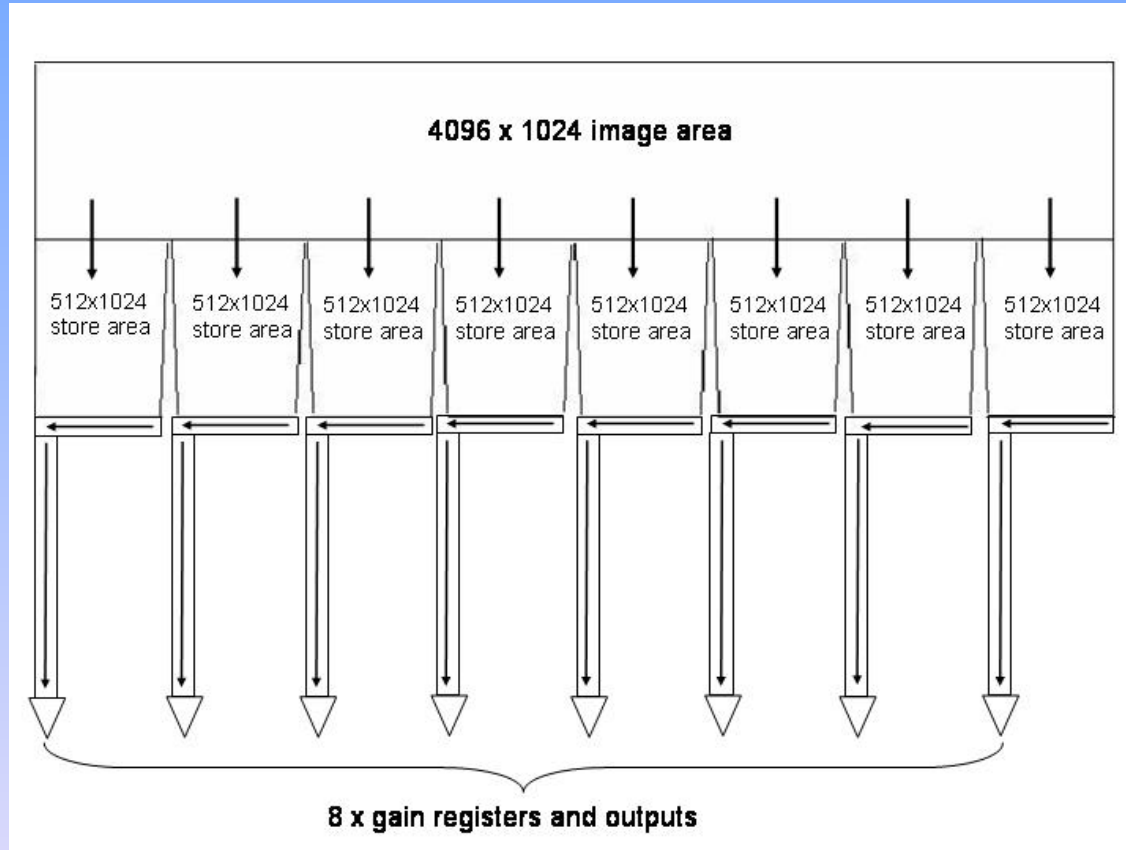
ULTRASPEC

Performance and Issues

New L3 CCD Proposal



New L3 CCD Proposal



Looking for £1M funding for new EM CCD to cover spatial/spectral range and increased read speeds because of FT architecture
ESO agreed to lend the NGC

Details of Specifications

4096 x 1024 pixels for imaging and likewise for storage

2 μ m-15 μ m square pixels, with 100% pixel fill factor.

8 outputs, 3 e rms at 100 kHz pixel but can operate at 7.5 MHz.

10 Hz full frame rate.

Thinned and back illuminated.

E2V Technologies “Astro” broadband AR coating.

2 phase vertical clocking.

A minimum of Grade 1 cosmetic quality.

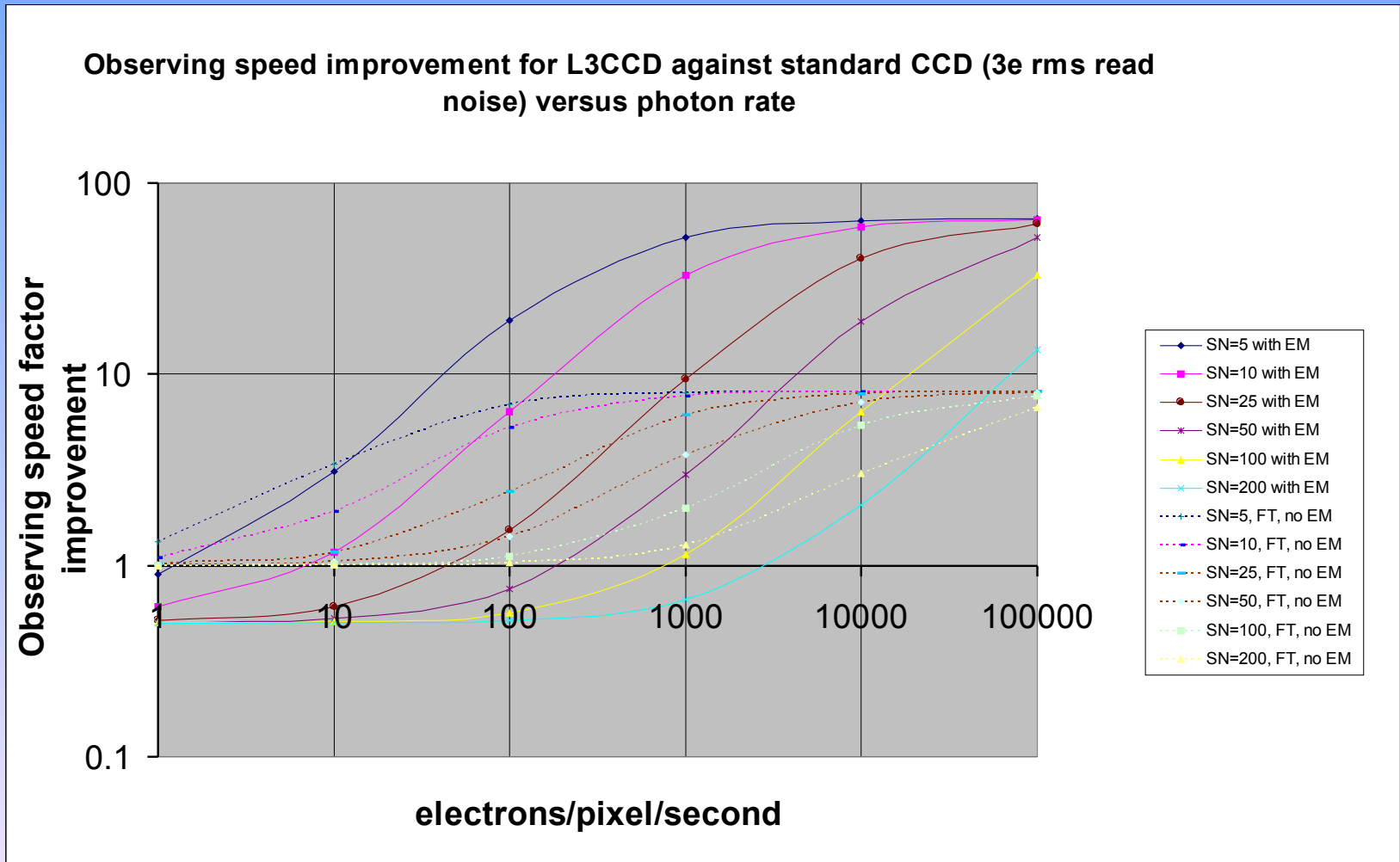
Flatness better than 15 μ m peak to valley across full length of detector.

Reference/dark rows, columns and blank elements to be supplied on the CCD.

Each of output to have separate Output Drain (OD) and Reset Drain (RD) pins.



Efficiency of the New Design



Thank You

